Features

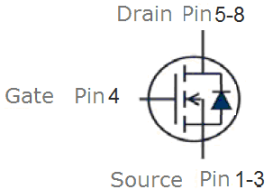
- N-Channel，5V Logic Level Control
- Enhancement mode
- Low on-resistance $R_{DS(on)}$ @ V_{GS}=4.5 V
- Fast Switching
- 100% Avalanche test
- Pb-free lead plating; RoHS compliant

Pb-Free RoHS HF Halogen-Free

V_{DS}	30	V
$R_{DS(on),TYP}$@ V_{GS}=10 V	2.5	mΩ
$R_{DS(on),TYP}$@ V_{GS}=4.5 V	3.4	mΩ
I_D	92	A

PDFN3333

Part ID	Package Type	Marking	Tape and reel information
VS3606AE	PDFN3333	3606AE	5000PCS/Reel



Maximum ratings, at T_A =25°C, unless otherwise specified

Symbol	Parameter		Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage		30	V
I_S	Diode continuous forward current	T_C =25°C	92	A
I_D	Continuous drain current@VGS=10V	T_C =25°C	92	A
		T_C =100°C	58	A
I_{DM}	Pulse drain current tested ①	T_C =25°C	368	A
EAS	Avalanche energy, single pulsed ②		81	mJ
P_D	Maximum power dissipation	T_C =25°C	42	W
VGS	Gate-Source voltage		±20	V
T_{STG} T_J	Storage and operating temperature range		-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Typical	Unit
$R_{\theta JC}$	Thermal Resistance-Junction to Case	3	°C/W
$R_{\theta JA}$	Thermal Resistance Junction-Ambient	35	°C/W

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ T_j=25°C (unless otherwise stated)						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	V_{GS}=0V I_D=250μA	30	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=30V,V_{GS}=0V	--	--	1	μA
	Zero Gate Voltage Drain Current(T_j=125℃)	V_{DS}=30V,V_{GS}=0V	--	--	100	μA
I_{GSS}	Gate-Body Leakage Current	V_{GS}=±20V,V_{DS}=0V	--	--	±100	nA
$V_{GS(TH)}$	Gate Threshold Voltage	V_{DS}=V_{GS},I_D=250μA	1.0	1.7	2.5	V
$R_{DS(ON)}$	Drain-Source On-State Resistance③	V_{GS}=10V, I_D=20A	--	2.5	3	mΩ
$R_{DS(ON)}$	Drain-Source On-State Resistance③	V_{GS}=4.5V, I_D=16A	--	3.4	5	mΩ
Dynamic Electrical Characteristics @ T_j = 25°C (unless otherwise stated)						
C_{iss}	Input Capacitance	V_{DS}=15V,V_{GS}=0V, f=1MHz	--	3635	--	pF
C_{oss}	Output Capacitance		--	550	--	pF
C_{rss}	Reverse Transfer Capacitance		--	520	--	pF
R_g	Gate Resistance	f=1MHz	--	1.2	--	Ω
Q_g	Total Gate Charge	V_{DS}=15V,I_D=20A, V_{GS}=10V	--	63	--	nC
Q_{gs}	Gate-Source Charge		--	13	--	nC
Q_{gd}	Gate-Drain Charge		--	16	--	nC
Switching Characteristics						
$t_{d(on)}$	Turn-on Delay Time	V_{DD}=15V, I_D=20A, R_G=3Ω, V_{GS}=10V	--	14	--	nS
t_r	Turn-on Rise Time		--	18	--	nS
$t_{d(off)}$	Turn-Off Delay Time		--	99	--	nS
t_f	Turn-Off Fall Time		--	45	--	nS
Source- Drain Diode Characteristics@ T_j = 25°C (unless otherwise stated)						
V_{SD}	Forward on voltage	I_{SD}=20A,V_{GS}=0V	--	0.78	1.2	V
t_{rr}	Reverse Recovery Time	T_j=25℃,I_{sd}=20A, V_{GS}=0V di/dt=100A/μs	--	32	--	nS
Q_{rr}	Reverse Recovery Charge			31		nC

NOTE:

① Repetitive rating; pulse width limited by max. junction temperature.

② Limited by T_{Jmax}, starting T_J = 25°C, L = 0.5mH, R_G = 25Ω, I_{AS} = 18A, V_{GS} =10V. Part not recommended for use above this value

③ Pulse width ≤ 300μs; duty cycle≤ 2%.

Typical Characteristics

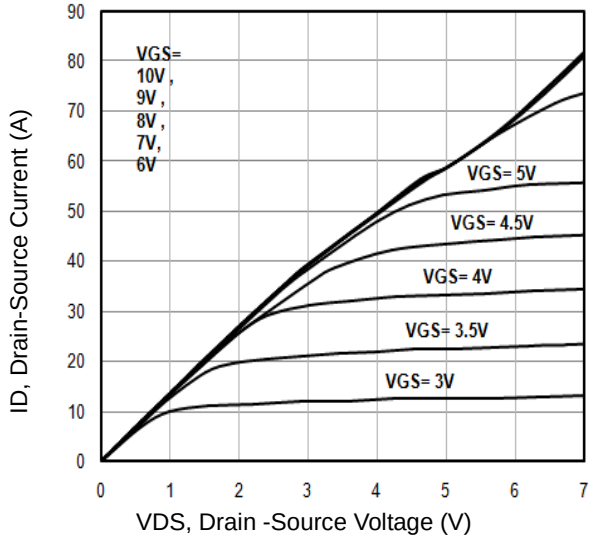


Fig1. Typical Output Characteristics

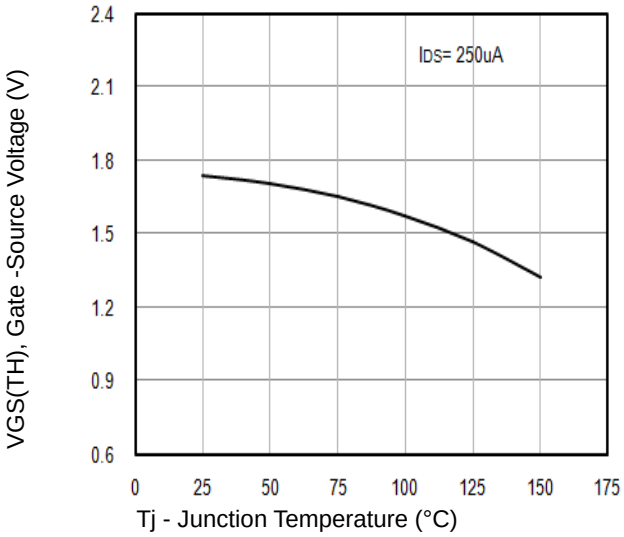


Fig2. $V_{GS(TH)}$ Gate -Source Voltage Vs.Tj

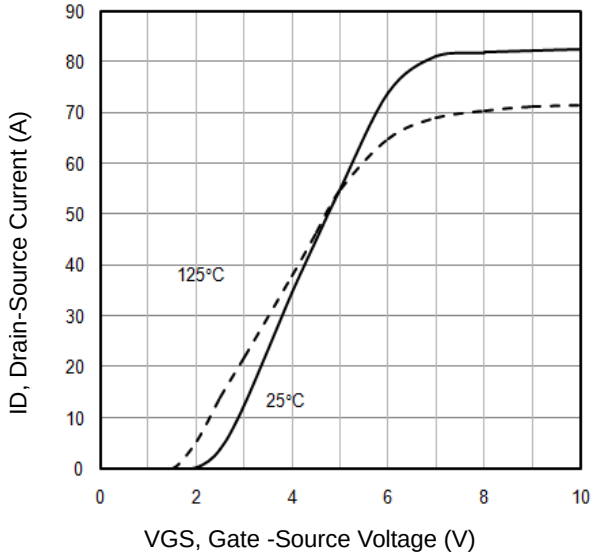


Fig3. Typical Transfer Characteristics

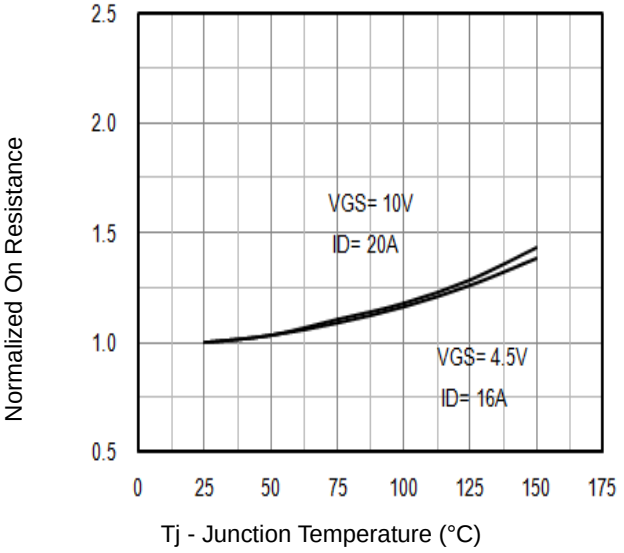


Fig4. Normalized On-Resistance Vs. Tj

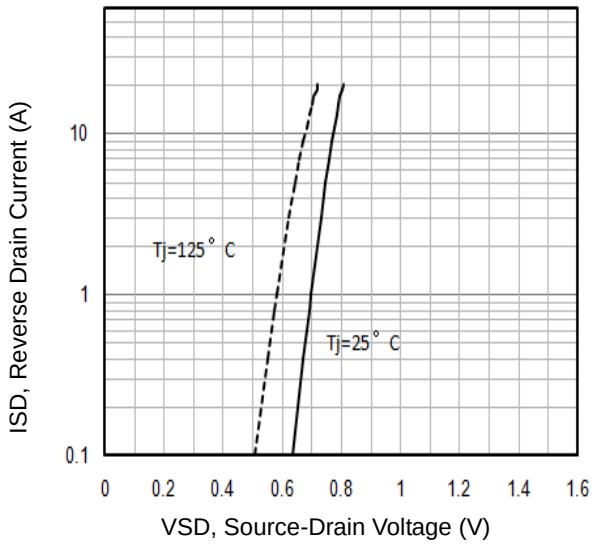


Fig5. Typical Source-Drain Diode Forward Voltage

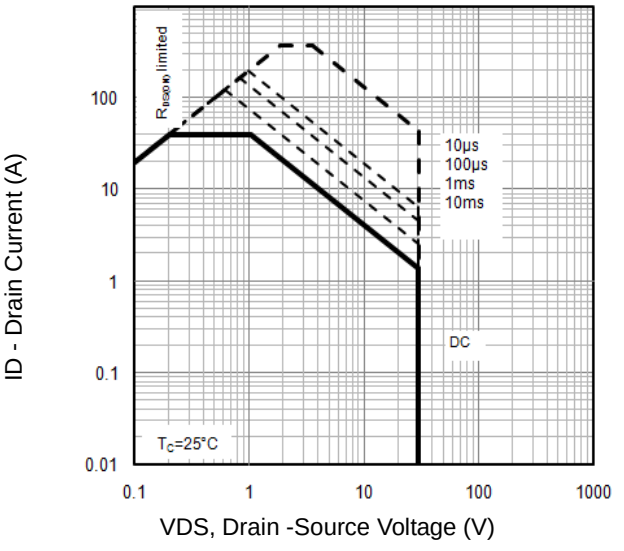


Fig6. Maximum Safe Operating Area

Typical Characteristics

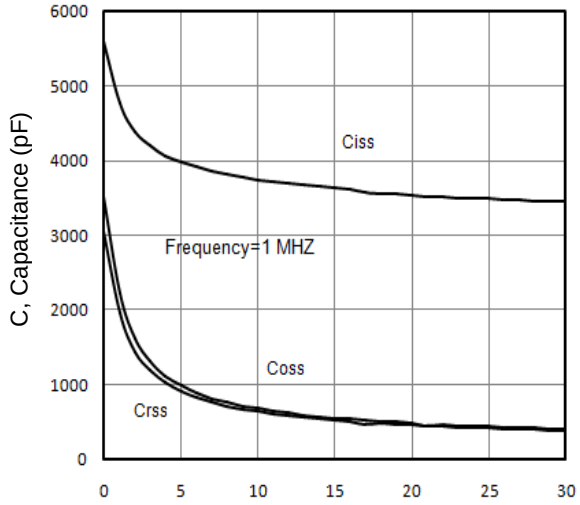


Fig7. Typical Capacitance Vs.Drain-Source Voltage

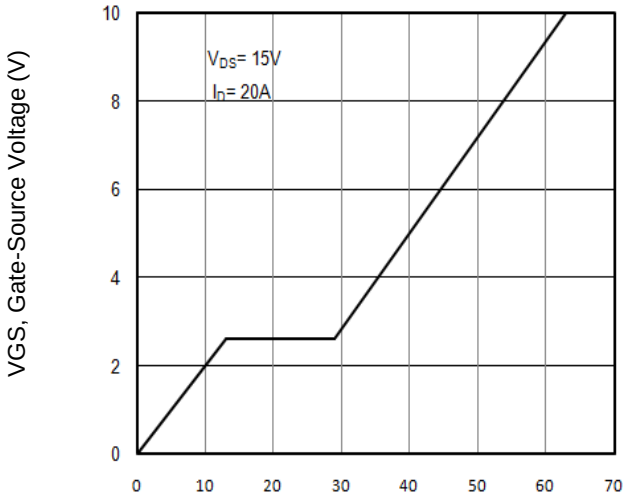


Fig8. Typical Gate Charge Vs.Gate-Source Voltage

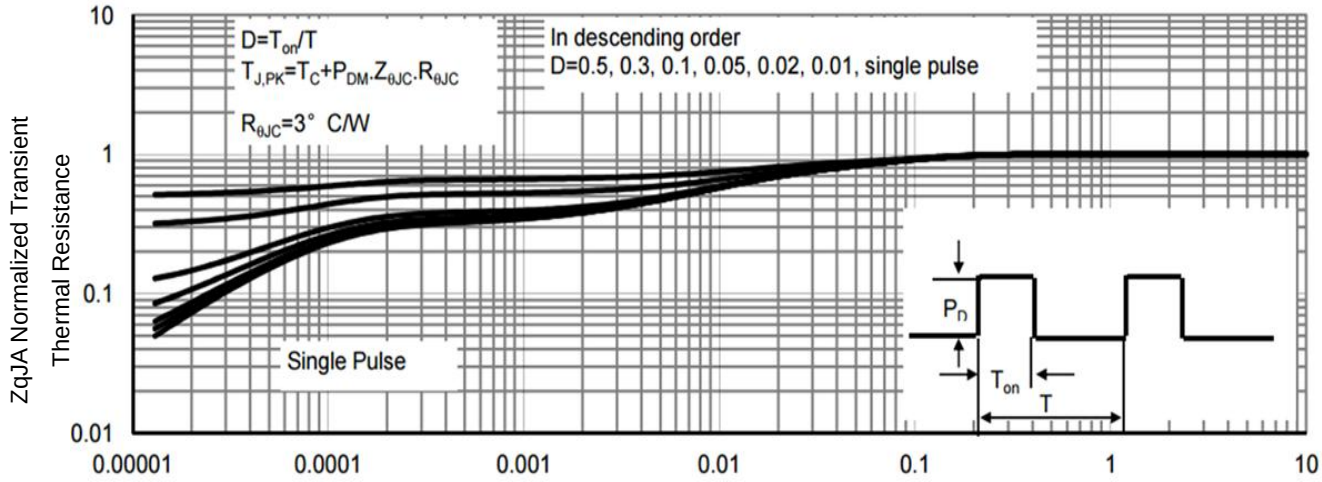


Fig9. Normalized Maximum Transient Thermal Impedance

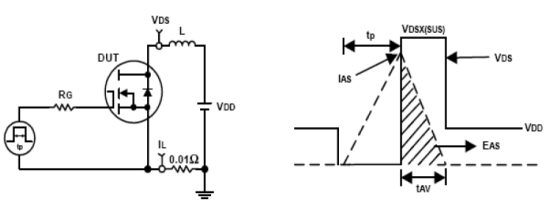


Fig10. Unclamped Inductive Test Circuit and waveforms

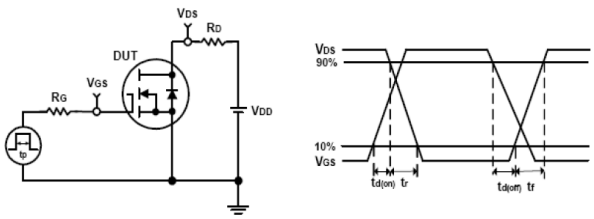
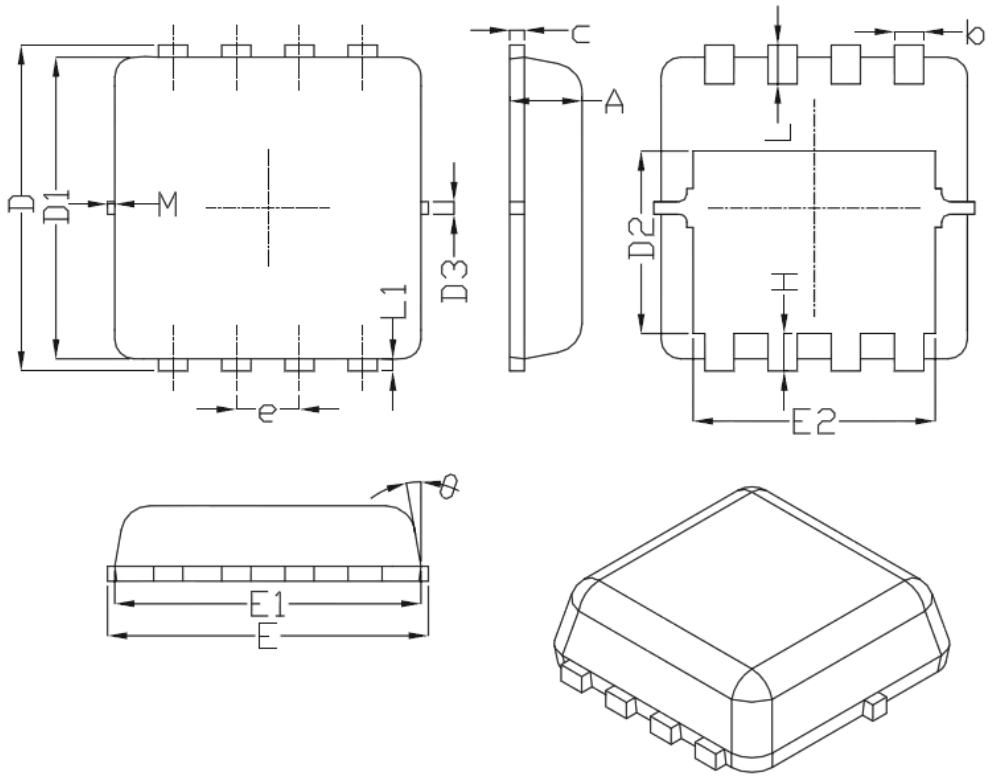


Fig11. Switching Time Test Circuit and waveforms

PDFN3333 Package Outline Data



DIMENSIONS (unit : mm)

Symbol	Min	Typ	Max	Symbol	Min	Typ	Max
A	0.70	0.75	0.80	**b**	0.25	0.30	0.35
C	0.10	0.15	0.25	**D**	3.25	3.35	3.45
D1	3.00	3.10	3.20	**D2**	1.78	1.88	1.98
D3	--	0.13	--	**E**	3.20	3.30	3.40
E1	3.00	3.15	3.20	**E2**	2.39	2.49	2.59
e	0.65BSC			**H**	0.30	0.39	0.50
L	0.30	0.40	0.50	**L1**	--	0.13	--
θ	--	10°	12°	**M**	*	*	0.15
*Not specified							

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